

# Top-down and Bottom-up Strategies for Generating Incremental Covering Arrays

**Abstract**—Combinatorial Testing (CT) is an effective technique for testing the interactions of factors in the Software Under Test (SUT). By designing an efficient set of test cases, i.e., a covering array, CT aims to check every possible valid interaction in SUT. Most existing covering array generation algorithms require a given degree  $t$  in prior, such that only the interactions with no more than  $t$  factors are to be checked. In practice, however, the value of  $t$  cannot be properly determined, especially for systems with complex interaction space. Hence, incremental covering arrays are preferred. In this paper, we propose two strategies (*Bottom-up* and *Top-down*) for generating incremental covering arrays which can increase the coverage strength when required. A comparative evaluation of these two strategies is performed on 55 software subjects (including 25 real-world software and 30 synthetic systems). The results shows that strategy *Bottom-up* have a significant advantage over strategy *Top-down*, and it also performs better than the traditional approach.

**Index Terms**—Combinatorial Testing, Covering Array, Incremental Covering Array, Bottom-up and Top-down strategy

## I. INTRODUCTION

With the growing complexity and scale of modern software systems, various factors, such as input values and configure options, can affect the behaviour of a system. Even worse, some interactions between them can trigger unexpected negative effects on the software. To ensure the correctness and quality of the software system, it is desirable to detect and locate these *bad* interactions. The simplest way to solve this problem is to perform exhaustive testing for all the possible valid interactions of the system. It is, however, not practical due to the combinatorial explosion. Therefore, the selection of a group of representative test cases from the whole testing space is required.

Combinatorial testing has been proven to be effective in sampling an effective set of test cases[1]. It works by generating a relatively small set of test cases, i.e., a covering array, to test the interactions involving a given number of factors that may affect the behavior of a system. The number of factors involved in those selected interactions is limited in a moderate range, which is usually from 2 to 6 [2].

Many algorithms have been proposed to generate covering arrays. Despite many differences between them, those works all assume that the degree  $t$  is a given priori. The degree  $t$  indicates the largest number of factors involved in the interactions to be covered, and the corresponding covering arrays which can satisfy this coverage criteria is called  $t$ -way covering arrays. In practice, however, the value of  $t$  is difficult to determine due to two reasons as follows. First, many software systems suffer from complex interaction space which make it challenging to estimate  $t$ . In such case, even

experienced testers can make mistakes and estimate a wrong value for  $t$ , which can significantly affect the effectiveness and efficiency of CT. Specifically, if  $t$  is estimated to be larger than required, many redundant test cases will be generated, which is a waste of computing resource. And if  $t$  is estimated to be smaller than required, then the generated covering array is not sufficient to obtain an effective test set. Second, even though  $t$  has been properly determined, there may not be enough time to completely execute all the test cases in the covering array. This is because testing software only makes sense before the next version is released. This time interval between two release versions may sometimes be too short for a complete testing of a high-strength covering array, especially in the scenario of continuous integration [3].

To address these shortcomings of traditional covering arrays, the notion of incremental covering array [3] has been proposed. Such object can be deemed as adaptive covering array, which can increase the degree  $t$  when required. As it can generate higher strength covering array based on lower strength covering array, it can reduce the cost when comparing with generating multiple ways of covering arrays. Additionally, it can be better applied on testing the software of which the released time is frequently changed and cannot be predicted. Another advantage for generating incremental covering array is that, testers can detect most faults in the software as soon as possible. This is because according to [2], most faults (about 70% to 80%) are caused by 2-degree interactions, and almost all faults can be covered by 6-way covering arrays. As incremental covering arrays first cover those lower-degree interactions, the faults caused by them will be detected sooner.

In consideration of the size of the total number of test cases, we argue that this approach of generating incremental covering array may produce too many test cases. This is obvious, as generating higher-strength covering array based on the lower-strength covering array (called *bottom-up* strategy later) does not aim to optimize the size of the higher-strength covering array. As a result, it may generate more test cases than those approaches that focus on generating a particular higher-strength covering array.

Then, a natural question, and also the motivation of this paper is, **is it possible to generate an incremental covering array with the same number of the overall test cases as those by the particular high-way covering array generation algorithms** ? Due to the obvious conclusion that any high way covering array must cover all the lower way interactions, the answer for this question is *yes*, as we can just apply a particular covering array generation algorithm to generate

the high-strength covering array, and then generate the lower-strength covering arrays by extracting some subset of the test cases which can cover all the lower degree interactions. We refer to this strategy as the *top-down* strategy.

In this paper, we propose these two strategies and evaluate their performance by comparing them at constructing several incremental covering arrays on 55 widely used subjects (including 25 real-world software and 30 synthetic systems). The results shows that strategy *Bottom-up* have a significant advantage over strategy *Top-down* at the size of covering arrays (especially for the lower-strength covering array) and the time cost. Additionally, strategy *Bottom-up* also performs better than the traditional approach.

Our contributions include:

- 1) We propose a formal description of incremental covering array, and give a proof of the existence of it.
- 2) We propose two strategies for generating incremental covering arrays.
- 3) We conduct a series of experiments to evaluate the characteristics of these two strategies, and compare the performance of our approach with traditional approach.
- 4) We offer a guideline for selecting which strategy when generating incremental covering array in practice.

## II. BACKGROUND

This section gives some formal definitions related to CT. Assume that the behaviour of SUT is influenced by  $k$  parameters, and each parameter  $p_i$  has  $a_i$  discrete values from the finite set  $V_i$ , i.e.,  $a_i = |V_i|$  ( $i = 1, 2, \dots, k$ ). Then a *test case* of the SUT is a group of values that are assigned to each parameter, which can be denoted as  $(v_1, v_2, \dots, v_k)$ . An  $t$ -degree interaction can be formally denoted as  $(-, \dots, v_{n_1}, -, \dots, v_{n_2}, -, \dots, v_{n_t}, -, \dots)$ , where some  $t$  parameters have fixed values and other irrelevant parameters are represented as "-". In fact, a test case can be regarded as a  $k$ -degree interaction.

### A. Covering array

**Definition 1.** A  $t$ -way covering array  $MCA(N; t, k, (a_1, a_2, \dots, a_k))$  is a test set in the form of  $N \times k$  table, where each row represents a *test case* and each column represents a parameter. For any  $t$  columns, each possible  $t$ -degree interaction of the  $t$  parameters must appear at least once. When  $a_1 = a_2 = \dots = a_k = v$ , a  $t$ -way covering array can be denoted as  $CA(N; t, k, v)$ .

For example, Table I (a) shows a 2-way covering array  $CA(5; 2, 4, 2)$  for the SUT with 4 boolean parameters. For any two columns, any 2-degree interaction is covered. Covering array has proven to be effective in detecting the failures caused by interactions of parameters of the SUT. Many existing algorithms focus on constructing covering arrays such that the number of test cases, i.e.,  $N$ , can be as small as possible.

### B. Incremental covering array

**Definition 2.** An incremental covering array  $ICA([N_{t_1}, N_{t_1+1}, \dots, N_{t_2}]; [t_1, t_2], k, (a_1, a_2, \dots, a_k))$  is a test set in the form of  $N_{t_2} \times k$  table, where  $t_1 < t_2$  and  $N_{t_1} < N_{t_1+1} <$

$\dots, < N_{t_2}$ . In this table, the first  $N_{t_1}$  lines ( $t_1 \leq t_i \leq t_2$ ) is a covering array  $MCA(N_{t_1}; t_1 + i, k, (a_1, a_2, \dots, a_k))$ .

When  $a_1 = a_2 = \dots = a_k = v$ , an incremental covering array can be denoted as  $ICA([N_{t_1}, N_{t_1+1}, \dots, N_{t_2}]; [t_1, t_2], k, v)$ .

Table I shows an example of incremental covering array, in which the two-way covering array  $CA(5; 2, 4, 2)$  is a subset of the three-way covering array  $CA(9; 3, 4, 2)$ , which is also an incremental covering array  $ICA([5, 9]; [2, 3], 4, 2)$ .

TABLE I: Experiment of Incremental covering array

(a)  $CA(5;2,4,2)$

0	0	1	0
1	0	0	0
1	1	1	0
0	1	0	1
1	0	1	1

(b)  $CA(9;3,4,2)$  &&  $ICA([5,9];[2,3],4,2)$

0	0	1	0
1	0	0	0
1	1	1	0
0	1	0	1
1	0	1	1
0	1	0	0
0	0	0	1
0	1	1	1
1	1	0	1

**Theorem.** For each covering array  $MCA(N_{t_2}; t_2, k, (a_1, a_2, \dots, a_k))$ , we can find an  $ICA([N_{t_1}, N_{t_1+1}, \dots, N_{t_2}]; [t_1, t_2], k, (a_1, a_2, \dots, a_k))$ , s.t., their test cases are the same.

*Proof.* We just need to prove that for any covering array,  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$ , we can find a  $MCA(N_{t-1}; t-1, k, (a_1, a_2, \dots, a_k))$ , such that,  $N_{t-1} < N_t$  and for any test case  $f \in MCA(N_{t-1}; t-1, k, (a_1, a_2, \dots, a_k))$ , it has  $f \in MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$ .

First,  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$  itself must be an  $MCA(N_t; t-1, k, (a_1, a_2, \dots, a_k))$ , as it must cover all the  $(t-1)$ -degree interactions.

Then, assume to obtain a  $(t-1)$ -way covering array, any one test case in  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$  can not be reduced. With this assumption, any test case will cover at least one  $(t-1)$ -degree interaction that only appears in this test case. Without loss of generality, let test case  $(v_1, v_2, \dots, v_k)$  cover the  $(t-1)$ -degree interaction  $(-, \dots, v_{p_1}, -, \dots, v_{p_2}, \dots, -, \dots, v_{p_{t-1}}, \dots, -, \dots, v_{p_t}, \dots, -, \dots)$  which only appears in the test case. Then obviously the  $t$ -degree interaction  $(v'_1, \dots, v_{p_1}, \dots, -, \dots, v_{p_2}, \dots, -, \dots, v_{p_{t-1}}, \dots, -, \dots, v_{p_t}, \dots, -, \dots)$  ( $v'_1 \neq v_1$ ) will never be covered by any test case in  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$ , and hence  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$  is not a  $t$ -way covering array (Note this is based on that the parameter can take on more than one value).

This is a contradiction, and means that we can reduce at least one test case in  $MCA(N_t; t, k, (a_1, a_2, \dots, a_k))$ , so that it is still a  $(t-1)$ -way covering array.  $\square$

This theorem shows the existence of the incremental covering arrays. As discussed before, generating the incremental covering arrays is of importance, as it supports adaptively

increasing the coverage strength. According to this theorem, when testing a SUT, testers can firstly execute the lowest-strength covering array in the incremental covering arrays, and then execute additional test cases from those higher-strength covering arrays as required. The reuse of previously executed test cases will reduce the cost for generating multiple different-ways covering arrays.

### III. GENERATING INCREMENTAL COVERING ARRAYS

This section presents two strategies to generate the incremental covering arrays. The first strategy, i.e., the *bottom-up* strategy starts from generating the lowest-strength covering array and then the higher-strength ones. The second strategy, i.e., the *top-down* strategy firstly generated the highest-strength covering array, then the lower-strength covering array.

#### A. Bottom-up strategy

This strategy is listed as Strategy 1. The inputs for this

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#### Strategy 1 Bottom-up strategy

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**Input:** *Params*  $\triangleright$  Parameters (and their values)  
 $t_1$   $\triangleright$  the lowest strength  
 $t_2$   $\triangleright$  the highest strength  
**Output:** *ICA*  $\triangleright$  the incremental covering arrays

```

1: ICA  $\leftarrow$  EmptySet
2: for  $t_i = t_1; t_i \leq t_2; t_i++$  do
3:   CAi  $\leftarrow$  EmptySet
4:   if  $t_i == t_1$  then
5:     CAi  $\leftarrow$  CA_Gen(Params,  $t_i$ )
6:   else
7:     CAi  $\leftarrow$  extend(Params,  $t_i$ , CAi-1)
8:   end if
9:   ICA.append(CAi)
10: end for
11: return ICA

```

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strategy consists of the values for each parameter of the SUT – *Params*, the lowest strength  $t_1$  of the covering array in the incremental covering array, and the highest strength  $t_2$  of the covering array. The output of this strategy is an incremental covering array – *ICA*.

This strategy generates the covering array from lower-strength to higher-strength (line 2). If the current coverage strength  $t_i$  is equal to  $t_1$ , it just utilizes a covering array generation algorithm to generate the particular covering array (line 4 - 5). Otherwise, it will first take the previous generated covering array *CA<sub>i-1</sub>* as seeds, and then utilize covering array generation algorithm to append additional test cases to satisfy higher coverage criteria (line 6 - 7).

Fig.1 presents an example for constructing *ICA*([6, 13, 24]; [2, 4], 5, 2) by this strategy. In this example, the covering array generation algorithm used is AETG [4]. The two-way covering array (test cases  $c_1$  to  $c_6$ ) is directly generated, and the three-way covering array (test cases  $c_1$  to  $c_{13}$ ) is generated by adding additional test cases (test cases  $c_7$  to  $c_{13}$ ) based on the previous two-way covering array. The four-way covering

c1	0	0	0	0	0
c2	1	1	1	1	0
c3	0	0	1	1	1
c4	1	1	0	0	1
c5	0	1	0	1	0
c6	1	0	1	0	0
c7	1	0	0	1	1
c8	0	1	1	0	1
c9	0	1	1	0	0
c10	0	0	0	0	1
c11	1	0	0	1	0
c12	0	1	0	1	1
c13	1	0	1	0	1
c14	1	1	0	0	0
c15	0	0	1	1	0
c16	1	1	1	1	1
c17	0	0	1	0	0
c18	1	0	0	0	0
c19	0	1	0	0	0
c20	0	0	0	1	0
c21	1	1	1	0	0
c22	0	1	1	1	0
c23	1	1	0	1	0
c24	1	0	1	1	0

Fig. 1: Bottom-up strategy example

array (test cases  $c_1$  to  $c_{24}$ ) is constructed on the previous three-way covering array. In total, to reach the 4-way covering array, 24 test cases are needed for this strategy.

#### B. Top-down strategy

This strategy is listed as Strategy 2, which generates covering arrays in the opposite order (line 2) of the bottom-up strategy. Similarly, if the current coverage strength  $t_i$  is equal to  $t_2$ , it directly generates the particular covering array (line 4 - 5). Otherwise, it will extract the covering array from a higher covering array (*CA<sub>i+1</sub>*) (line 6 - 7).

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#### Strategy 2 Top-down strategy

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**Input:** *Params*  $\triangleright$  Parameters (and their values)  
 $t_1$   $\triangleright$  the lowest strength  
 $t_2$   $\triangleright$  the highest strength  
**Output:** *ICA*  $\triangleright$  the incremental covering arrays

```

1: ICA  $\leftarrow$  EmptySet
2: for  $t_i = t_2; t_i \geq t_1; t_i--$  do
3:   CAi  $\leftarrow$  EmptySet
4:   if  $t_i == t_2$  then
5:     CAi  $\leftarrow$  CA_Gen(Params,  $t_i$ )
6:   else
7:     CAi  $\leftarrow$  extract(Params,  $t_i$ , CAi+1)
8:   end if
9:   ICA.append(CAi)
10: end for
11: return ICA

```

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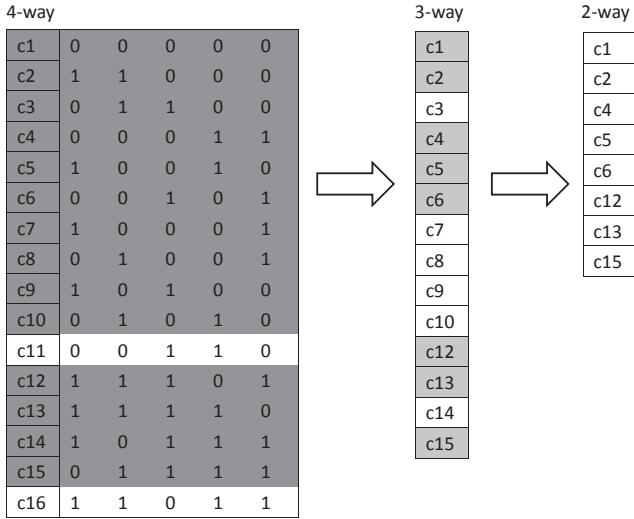


Fig. 2: Top-down strategy example

An example for this strategy is given in Fig.2. In this example, we first generated the 4-way covering array  $CA(16; 4, 5, 2)$ . Then we selected 14 test cases to form a three-covering array  $CA(14; 3, 5, 2)$ . Next the two-way covering array  $CA(8; 2, 5, 2)$  is extracted from  $CA(14; 3, 5, 2)$ . The rows with dark background from the higher-strength covering arrays represent those selected test cases.

From the two examples, an obvious observation is that for the *top-down* strategy, it has a significant advantage over the *bottom-up* strategy with respect to the size of the 4-way covering array (16 test cases generated by *top-down*, while 24 by *bottom-up*). But when considering the lower-strength covering arrays, the *bottom-up* strategy performs slightly better (13 and 6 by *bottom-up* for degree 3 and 2, respectively; while 14 and 8 by *top-down*).

#### IV. IMPLEMENTATION OF THE APPROACH

In this section, we will describe a specific implementation of the two strategies proposed in the previous section.

##### A. Covering array generation method

Our covering array generation approach is IPOG [5], [6], [7], which firstly builds a  $t$ -way test set for the first  $t$  parameters, then extends the test set to build a  $t$ -way test set for the first  $t+1$  parameters, and then continues to extend the test set until it builds a  $t$ -way test set for all the parameters. We select this algorithm mainly because it is very efficient, that is, it can quickly generate a  $t$ -way covering array even though  $t$  is a relatively large number (up to 6). This is important, as in our experiments, some subjects contain an extremely large input space, which is unfavorable to apply some time-consuming covering array generation approaches.

##### B. Constraints handling

Our constraints handling technique is based on Minimum Forbidden Tuples (MFTs) [8], [9], which is well supported

by IPOG generation algorithm. A forbidden tuple is a tuple as the value assignment of some parameters that violates constraints. A minimum forbidden tuple is a forbidden tuple of minimum size that covers no other forbidden tuples. Given some constraints for one SUT, we should compute all the MFTs of the SUT, and then limit the test cases to the ones that do not contain any tuple in the MFTs.

##### C. Seeding test cases

When given a lower-way covering array as seeds, we need to eliminate those higher-degree tuples that have already been covered by this covering array. After this, we need to generate additional test cases to cover the un-covered higher-degree tuples until all the higher-degree tuples are covered.

##### D. Extract lower-way covering array

This is the key part for the top-down strategy. Considering the test cost, it is desirable to obtain a minimal  $t$ -way covering array  $CA_t$  from a  $t+1$ -way covering array  $CA_{t+1}$ . However, this is impractical if  $CA_{t+1}$  is too large, because to get the minimal  $CA_t$ , we need to exhaustively check every possible subset of the  $CA_{t+1}$ . Hence, in this paper, we decide to adopt a greedy method. Specifically, at each iteration, we will select the test case from  $CA_{t+1}$  which has the longest hamming distance from the test cases that have already been selected. The hamming distance between two test cases, say,  $c_1$  and  $c_2$ , is computed in the following formula:

$$\frac{\#the \text{ num of different elements between } c_1 \text{ and } c_2}{\#the \text{ num of all the elements in } c_1 \text{ and } c_2}$$

The selection process repeats until we obtain a complete  $t$ -way covering array.

## V. EXPERIMENTS AND RESULTS

### A. Research Questions

We set up the following three research questions to investigate the effectiveness and the efficiency of the two strategies.

**RQ1. What is the size of the incremental covering array generated by the two strategies *bottom-up*, and *top-down*?**

To evaluate the two strategies, the size of the covering array is one important metric. In CT, the main goal is to make the size of the covering array as small as possible. With respect to the incremental covering array, instead of focusing on one covering array, we should evaluate all the covering arrays with different strengths in it. How to apply the two strategies in practice depends on what strength of the covering arrays they are good at generating. For example, if one strategy can generate smaller size of lower-way covering array, it is a better choice at generating incremental covering array within a short testing time (current software under testing will be soon expired for the releasing of the next version). On the contrary, if one strategy can generate smaller size of higher-way covering array, it is better to be applied on testing the software within a long testing time.

**RQ2. How efficient is the two strategies?**

The time that is needed to generate covering array is also a very important metric to evaluate the two strategies. Many approaches in CT is limited to a given time budgeted for searching the optimal covering arrays. But when apply covering array in practice, it is normally not possible to obtain a proper time budgeted in prior. Hence, it is necessary to optimize the covering array generation process to reduce the time cost. Similar to our first research question, we will investigate the time to generate the covering arrays with different test strengths in the incremental covering array.

**RQ3. Compared with the traditional approach, do the two strategies have any advantages at effectiveness and efficiency?**

At last, we need to compare our strategies with traditional approach. To our best knowledge, the study in [3] is the only research that aims at handling the incremental covering array generation problem. We need to investigate the differences between it with our two strategies, and also need to make a comparative evaluation among them. Specifically, it is needed to obtain the size of the incremental covering array and the generation time cost of this approach, and compare them with that of these two strategies proposed in this paper.

**B. Benchmarks**

We used 55 SUT as the subjects of our experiments, which are shown in Table II. These subjects are widely used to evaluate the performance of the covering array generation approach. Among these subjects, the first 20 subjects (from *Banking1* to *Telecom*), are obtained from a recent benchmark created by Segall et al [10], which have already been used in several works [11], [12]. These 20 subjects cover a wide range of applications, including telecommunications, health care, storage and banking systems. The following five subjects (from *SPIN-S* to *Bugzilla*) were firstly introduced by Cohen et al. [13], [14]. Among them, *SPIN-S* and *SPIN-V* are two components for model simulation and verification, *GCC* is a compiler system, *Apache* is a web server application, and *Bugzilla* is a web-based bug tracking system. These five subjects have been widely used in literatures [15], [13], [14], [16], [17], [18], [12]. The last 30 (from *Syn1* to *Syn30*) are synthetic subject models that are generated by Cohen et al. [14]. These synthetic subject models are designed with similar characterization (input space, constraints, etc.) of those real subjects and have been used in following studies [16], [17], [18], [12].

In Table II, the model is presented in the abbreviated form  $\#values\#number\ of\ parameters$ , e.g.,  $7^36^2$  indicates the software has 3 parameters that can take 7 values and 2 parameters take 6 values. The constraint is presented in the form  $\#degree\#number\ of\ constraints$ , e.g.,  $2^33^{18}$  means that the SUT contains 3 constraints with 2-degree and 18 constraints with 3-degree.

**C. Experiment set-up**

For each SUT listed in Table II, we adopted the two strategies, i.e., *Top-down* and *Bottom-up*, to generate an incremental

TABLE II: The models of the SUT

Name	Model	Constraint
Banking1	$3^44^1$	$5^{112}$
Banking2	$2^{14}4^1$	$2^3$
CommonProtocol	$2^{10}7^1$	$2^{10}3^{10}4^{12}5^{96}$
Concurrency	$2^5$	$2^43^{15}2$
Healthcare1	$2^63^25^16^1$	$2^33^{18}$
Healthcare2	$2^53^64^1$	$2^{13}6^51^8$
Healthcare3	$2^{16}3^64^55^16^1$	$2^{31}$
Healthcare4	$2^{13}3^{12}4^65^26^17^1$	$2^{22}$
Insurance	$2^63^{15}5^{16}2^{11}1^{13}1^{17}3^{11}$	-
NetworkMgmt	$2^24^{15}3^{10}2^{11}1^1$	$2^{20}$
ProcessorComm1	$2^33^64^6$	$2^{13}$
ProcessorComm2	$2^33^{12}4^85^2$	$1^42^{121}$
Services	$2^33^45^28^210^2$	$3^{38}6^42$
Storage1	$2^{13}4^{14}5^1$	$4^{95}$
Storage2	$3^46^1$	-
Storage3	$2^93^{15}5^36^{18}1$	$2^{38}3^{10}$
Storage4	$2^53^74^{15}5^26^27^19^{11}3^1$	$2^{24}$
Storage5	$2^53^85^36^28^19^{11}10^{211}1^1$	$2^{151}$
SystemMgmt	$2^53^45^1$	$2^{13}3^4$
Telecom	$2^53^{14}2^516^1$	$2^{11}3^{14}9$
SPIN-S	$2^{13}4^5$	$2^{13}$
SPIN-V	$2^{42}3^24^{11}$	$2^{47}3^2$
GCC	$2^{18}9^{10}$	$2^{37}3^3$
Apache	$2^{15}8^38^44^516^1$	$2^33^{14}2^51$
Bugzilla	$2^{49}3^{14}2$	$2^43^1$
Syn1	$2^{86}3^34^{15}5^62$	$2^{20}3^34^1$
Syn2	$2^{86}3^34^35^16^1$	$2^{19}3^3$
Syn3	$2^{27}4^2$	$2^93^1$
Syn4	$2^513^44^25^1$	$2^{15}3^2$
Syn5	$2^{155}3^74^35^56^4$	$2^{32}3^64^1$
Syn6	$2^{73}4^36^1$	$2^{26}3^4$
Syn7	$2^{29}3^1$	$2^{13}3^2$
Syn8	$2^{109}3^24^25^36^3$	$2^{32}3^44^1$
Syn9	$2^{57}3^{14}1^516^1$	$2^{30}3^7$
Syn10	$2^{130}3^64^55^26^4$	$2^{40}3^7$
Syn11	$2^{84}3^44^25^26^4$	$2^{28}3^7$
Syn12	$2^{136}3^44^35^16^3$	$2^{23}3^4$
Syn13	$2^{124}3^44^15^26^2$	$2^{22}3^4$
Syn14	$2^{81}3^54^36^3$	$2^{13}3^2$
Syn15	$2^{50}3^44^{15}5^26^1$	$2^{20}3^2$
Syn16	$2^{81}3^34^26^1$	$2^{30}3^4$
Syn17	$2^{128}3^34^25^16^3$	$2^{25}3^4$
Syn18	$2^{127}3^24^45^66^2$	$2^{23}3^44^1$
Syn19	$2^{172}3^94^95^36^4$	$2^{38}3^5$
Syn20	$2^{138}3^44^55^46^7$	$2^{42}3^6$
Syn21	$2^{76}3^34^25^16^3$	$2^{40}3^6$
Syn22	$2^{72}3^44^16^2$	$2^{31}3^4$
Syn23	$2^{25}3^{16}1$	$2^{13}3^2$
Syn24	$2^{110}3^25^{16}4$	$2^{25}3^4$
Syn25	$2^{118}3^64^25^{16}4$	$2^{23}3^34^1$
Syn26	$2^{87}3^{14}3^54$	$2^{28}3^4$
Syn27	$2^{55}3^24^25^{16}4$	$2^{17}3^3$
Syn28	$2^{167}3^{16}4^25^36^6$	$2^{31}3^6$
Syn29	$2^{134}3^75^3$	$2^{19}3^3$
Syn30	$2^{73}3^34^3$	$2^{20}3^2$

covering array from 2-way to 6-way. The size of each covering array contained in this incremental covering array is recorded. We also record the time (seconds) that is consumed to generate these covering arrays.

Besides these two strategies, we also adopted the strategy proposed in the study [3] to generate these incremental covering arrays. This strategy can be regarded as one special bottom-up strategy, but with one difference: it should generate

a higher-way covering array at first, and then take some part in it to fill in the lower-covering array.

Note that the study [3] did not give a specific implementation of the strategy. Hence, in this paper, we implemented this strategy with the covering array generation approach—IPOG, which is the same approach used in our strategies. By doing this, we can eliminate the influence from the covering array generation approach, and only focus on the performance among different strategies. Another point that needs to note is that the approach listed in [3] generates three distinct incremental covering arrays for one SUT. Generating multiple covering arrays can increase their abilities to handle the random or non-determined failures. To make a fair comparison, we only record one covering array in it (with the minimal size among the three covering arrays), and the corresponding time that is needed to generate it.

We ran all the experiments on a server which has a 6-core CPU of 2.0GHz (Intel Xeon E5-2640 v2), and a 16 GB memory. It took us two weeks in total to obtain all the results. Note that not all the covering arrays can run up to 6 way because of the memory limitation and computing time.

#### D. Results and Discussion

The results are listed in Fig. 3 and Fig. 4 for covering array size and consuming time, respectively. There are 55 sub figures in these two main figures, one for each subject. In each subject, the x axis lists the covering array strength, which is ranged from 2-way to 6-way. The y axis shows the size of each covering array, which is normalized to between 0 to 1. There are three polygonal lines in each sub-figure, each of which shows the results for one of the three strategies: *Bottom-up*, *Top-down*, and *Traditional* [3].

One important observation in this figure is that there is a significant advantage of strategy *Bottom-up* over *Top-down* at the size of covering arrays. Specifically, among the 55 subjects, there are 55 subjects (all the subjects) on which *Bottom-up* generates smaller size of 2-way covering array than *Top-down*, 50 subjects on 3-way covering array, 28 subjects on 4-way covering array, and 12 subjects on 5-way covering array. In contrast, *Top-down* only generates smaller size of test cases for 3 subjects on 3-way covering array, 20 subjects on 4-way, 10 subjects on 5-way, and 11 subjects on 6-way.

We list these comparative data in Table III. Column “Bottom-up” shows the number of subjects that strategy *Bottom-up* performs better. We attached the number of test cases that is decreased on average in the parentheses. Column “Top-down” shows the better results for strategy *Top-down*, and Column “Equal” shows the number of subjects that these two strategies generate the same size of covering array.

Based on Table III, we can learn that, besides the number of subjects, *Bottom-up* strategy also has a significant advantage on the extent to which it has decreased the size of test cases. In fact, *Bottom-up* strategy has decreased the number of test cases ranged from 270 to 657 on average, while *Top-down* strategy just decreased the number of test cases no more than 40.

TABLE III: Comparative data between two strategies (Size)

Degree	Bottom-up	Top-down	Equal
	#subjects (#test cases)	#subjects (#test cases)	
2	55 (270.04)	0 (-)	0
3	50 (624.4)	3 (39.0)	2
4	28 (657.71)	20 (36.95)	3
5	12 (638.42)	10 (39.0)	3
6	0 (-)	11 (38.55)	0

Above all, the answer to research question 1 is:

**Except for the highest-way (6-way) covering array on which *Top-down* strategy has a slight advantage, it falls far behind strategy *Bottom-up* at the size of generated covering array.**

One reason for this result is because the method to extract lower-way covering arrays from higher coverings is not optimal. As mentioned before, considering of the efficiency, we use a greedy method to select test cases from higher covering arrays. This may result in that, for strategy *Top-down*, the number of test cases of the lower-way covering array may be larger than needed. We believe another reason for this result is the covering array generation approach IPOG. This is because that even though for higher-way covering array (6-way), strategy *Top-down* did not have any significant advantages over *Bottom-up*, which indicates that IPOG is not good at generating higher-way covering array.

With respect to the second research question, we can also find that *Bottom-up* performs better than *Top-down*. Similar to the first question, we list the comparative data of time cost in Table IV. Column “Bottom-up” shows the number of subjects that strategy *Bottom-up* performs better. We also attached the seconds that are decreased on average to generate the covering array in the parentheses. Column “Top-down” shows the better results for strategy *Top-down*.

TABLE IV: Comparative data between two strategies (Time)

Degree	Bottom-up	Top-down
	#subjects (#seconds)	#subjects (#seconds)
2	49 (27.17)	6 (0.05)
3	53 (98.82)	2 (0.01)
4	48 (456.41)	3 (0.01)
5	21 (589.39)	4 (0.44)
6	8 (205.44)	3 (2.18)

From this table, it is easy to conclude that for most subjects, strategy *Bottom-up* performs more efficiently with respect to the time cost. In fact, the time reduction of *Bottom-up* is ranged from 27 seconds to 289 seconds, while *Top-down* reduced less than 1 second for most subjects.

Besides this, another important observation is that strategy *Bottom-up* can run more higher-way covering arrays. Specifically, there are 4 subjects (‘Insurance’, ‘NetworkMgmt’, ‘Storage4’, and ‘Storage5’) on which *Bottom-up* can run more 4-way covering arrays than *Top-down*, 14 subjects (‘Healthcare3’, ‘Healthcare4’, ‘Insurance’, ‘NetworkMgmt’, etc.) that can run more 5-way covering arrays, and 10 subjects (‘Healthcare3’, ‘Healthcare4’, ‘Insurance’, ‘NetworkMgmt’, ‘Proces-



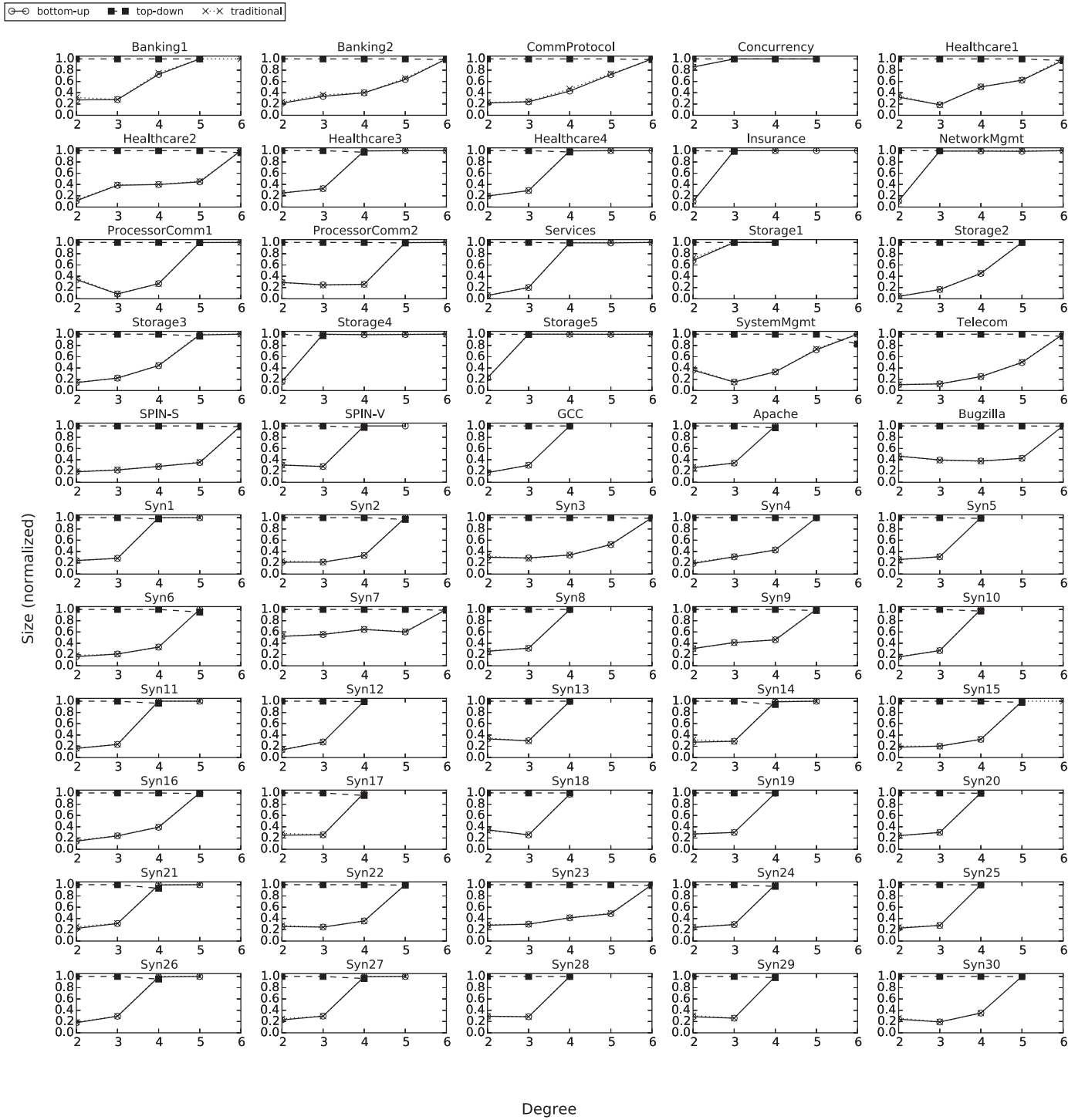


Fig. 3: The comparison of the three strategies with respect to the size of covering arrays

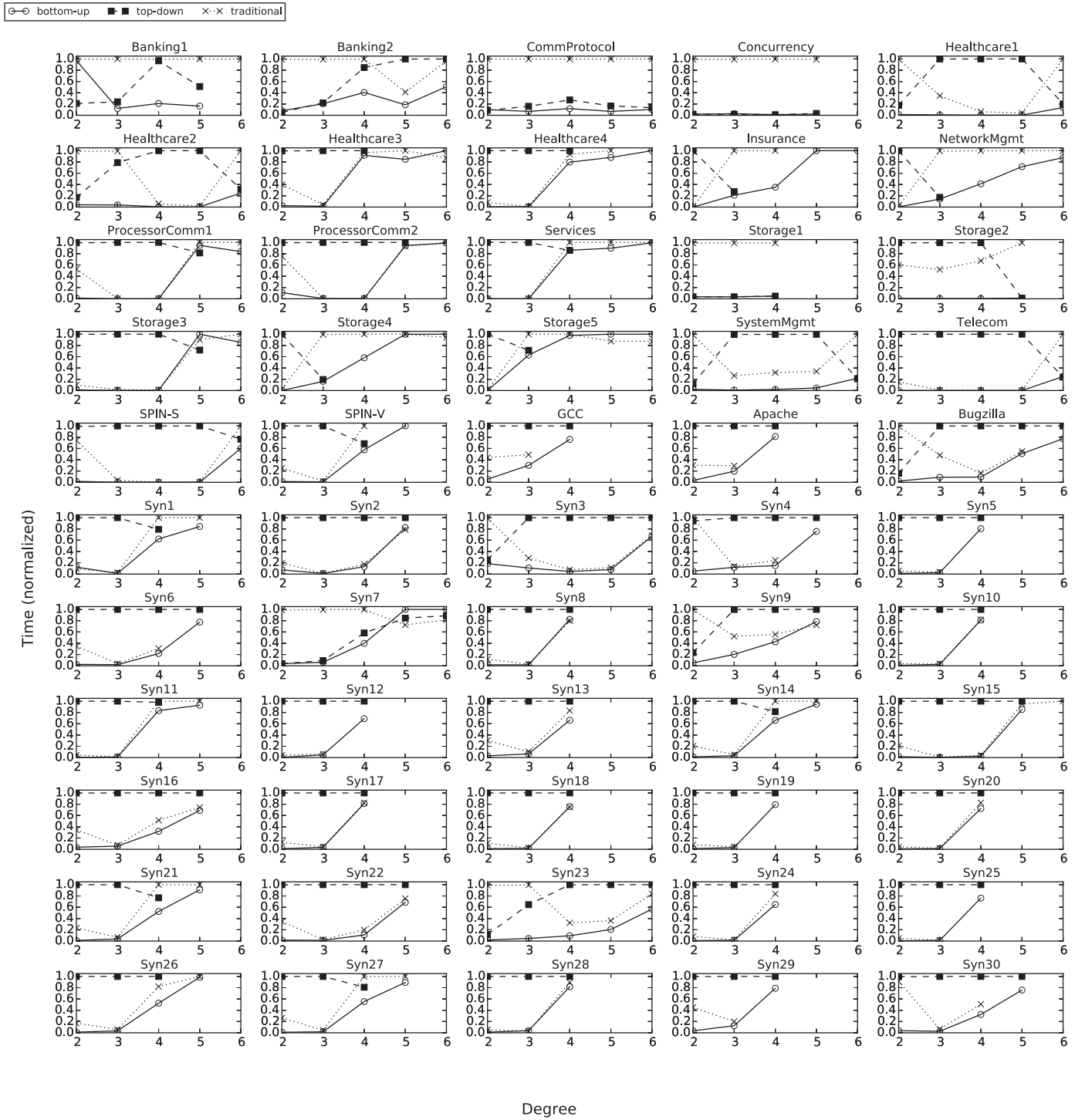


Fig. 4: The comparison of the three strategies with respect to the time cost



sorComm1', etc.) that can run more 6-way covering arrays. For these subjects, strategy *Top-down* can not completely obtain the corresponding higher-way covering arrays within a proper time limitation.

Hence, the answer to the second question is :

**Strategy *Bottom-up* is the better approach when considering the time cost for generating incremental covering array.**

For the last research question, there are several observations:

At first sight of Fig 3, we can hardly distinguish the traditional approach and *Bottom-up* strategy, which indicates that the two strategies has a similar performance at the size of generated covering array. This is easy to understand, as we mentioned before, the approach [3] is also a special version of *Bottom-up* strategy. But on closer inspection, these still exists differences between them.

TABLE V: Compare traditional approach with Bottom-up strategy (Size)

Degree	Bottom-up	Traditional	Equal
	#subjects (#test cases)	#subjects (#test cases)	
2	45 (2.33)	6 (0.83)	4
3	24 (1.82)	21 (2.33)	10
4	24 (11.53)	7 (2.24)	17
5	18 (69.33)	2 (1.0)	14
6	1 (48.67)	1 (2.0)	16

We list the comparative data in Table V, which is similar to Table III. We can learn that there is a slight advantage (around 1 to 69 test case) of our approach *Bottom-up* over the traditional approach.

With respect to the time cost, it is easy to figure out that our approach *Bottom-up* performs better than the traditional approach. Similar to the size, we list the comparative data in Table VI for a clear view. In this table, we can learn that almost for all the subjects (54 for degree 2, 54 for degree 3, 46 for degree 4, 28 for degree 5, and 14 for degree 6), our approach *Bottom-up* costs less time than the traditional approach. The reason why our approach performs more efficiently is mainly because our approach does not need to generate a higher-way covering array in prior. This task is very time-consuming if the input space is too large.

TABLE VI: Compare traditional approach with Bottom-up strategy (Time)

Degree	Traditional	Top-down
	#subjects (#seconds)	#subjects (#seconds)
2	54 (0.18)	1 (0.08)
3	54 (0.82)	1 (5.9)
4	46 (80.19)	2 (30.4)
5	28 (716.38)	6 (181.64)
6	14 (2.31)	4 (431.43)

We do not give a closer inspection for comparing the traditional approach with *Top-down* strategy. This is because based on Fig. 3 and Fig. 4, we can easily find that the traditional approach also has a significant advantage over *Top-down* strategy at the covering array size and time cost.

Above all, the answer to the 3rd question is:

**With respect to the size of incremental covering array, strategy *Bottom-up* is slightly better than the traditional approach. Strategy *Bottom-up* also needs less time than the traditional approach to generate the covering arrays.**

## VI. THREATS TO VALIDITY

There are several threats to validity in our studies.

First, our incremental covering array generation approach is implemented by using IPOG. Although IPOG can efficiently generate higher-way covering array for the SUT with large input space, it may generate too many test cases (due to the greedy strategy). It is necessary to try more covering array generation approaches to make the conclusion more general.

Second, the method to extract lower-way covering arrays from higher coverings is a greedy algorithm in this paper. This may result in that the size of the lower-way covering arrays generated by *Top-down* strategy may be larger than needed. If adopted some other methods, e.g., the post-optimal approach [19], [20], the number of test cases generated by *Top-down* strategy may be significantly decreased.

At last, our results are based on the 55 wildly used input models. That is, with other input models, the results may be different from this paper. It is appealing to further study the influence of the characteristics of the input models, e.g., the number of parameters, and the constraints, on the results of incremental covering array generation approach.

## VII. RELATED WORK

Combinatorial testing has been proven to a effective testing technique in practice [21], especially on domains like configuration testing [22], [23], [24] and software inputs testing [4], [25], [26]. The most important task in CT is to generate covering arrays, which support the checking of various valid interactions of factors that influence the system under testing.

Nie et al. [1] gave a survey for combinatorial testing, in which the methods for generating covering arrays are classified. However, traditional static covering arrays can be hardly directly applied in practice, hence many adaptive methods are proposed.

Cohen et al. [27], [14] studied the constraints that can render some test cases in the covering array invalid. They proposed a SAT-based approach to avoid the impact. Nie et al.[28] proposed a model for adaptive CT, in which both the failure-inducing interactions and constraints can be dynamically detected and removed in the early test cases generation iteration. Further, the coverage strength of covering array can be adaptively changed as required.

S.Fouché et al. [3] proposed the incremental covering array, and gave a method to generate it. The method can be deemed as a special case of *bottom-up* strategy, with the only difference being that it used multiple lower-strength covering arrays instead only one in this paper to construct the higher-strength covering array. This is because their work needs to characterize the failure-inducing interactions in the covering array, in which multiple covering arrays can support a better diagnosis.

Calvagna et al. [29] proposed another work to generate higher-way in an iterative way. Different than our work, its main task to generate a covering array with a specific given degree. It builds a relationship between higher-way covering array with lower-covering array. Based on this, it can reduce the higher-way covering array generation problem to multiple lower covering array generation problem.

## VIII. CONCLUSIONS AND FUTURE WORKS

Incremental covering array is an important object to make CT used in practice, because it makes CT more adaptive, such that we do not need to give the specific test strength in prior. This paper formally defined the incremental covering array and gave a proof to its existence. Furthermore, this paper proposed two strategies for generating incremental covering arrays. Experimental results show that strategy *bottom-up* have a significant advantage over *top-down* at the size of the covering arrays and time cost. It is also performs more efficient than traditional approach with respect to the time cost.

As a future work, we will apply more covering array generation algorithms, to compare their performance at generating incremental covering arrays. Another interesting work is to combine the two strategies, so that we can first select a median coverage strength  $t$  and generate incremental covering arrays by *top-down* strategy. Then if the maximal-way covering array is generated, we can use *bottom-up* strategy to generate further higher-strength covering arrays. We believe such a combination strategy may offer a better performance.

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